IN THE CLAIMS:

1. (Currently Amended) A scanning system based on the principle of confocal microscopy, comprising a light source (1), imaging optics (4) for focusing the light (5) emitted from the light source (1) onto an object (6) to be scanned, furthermore comprising an image detector (10) to detect the light (7) of a point (6') on the object (6) that is backscattered from the object (6) and that passes back through the same imaging optics (4) to at least two radiation-sensitive sensor elements (13, 14) (pixel), characterized in that wherein

at least two sensor elements (13.14) are assigned to an object point irradiated via the imaging optics (4, 9),

means (11) for changing the length of the optical path (d) are provided in the beam path between the aperture array (3) and the object (6), which optical distance (d) of the image plane can be varied in a specified manner, and

means are provided which influence the accumulation of charges (Q13, Q14) in the at least two sensor elements (13, 14) from the intensity of light of the observed beam path (7) during the exposure period (T) in such a manner that a correlation with the optical distance (d) of the image plane from the imaging optics (4) is created so that an altitude coordinate (zs) of the object (6) can be reconstructed from the

66489-111-7

distribution of the levels of intensity acquired from the at least two sensor elements (13, 14) during an exposure period (T).

- 2. (Currently Amended) A scanning system as defined in Claim 1, characterized in that wherein said means alter the sensitivity of said sensor elements (13, 14) and/or the translucence in the observed beam path (7) between said imaging optics (4) and said image detector (10), particularly said exposed area of said at least two sensor elements (13.14).
- 3. (Currently Amended) A scanning system as defined in Claim 1 or Claim 2, characterized in that , wherein an aperture array (3) is provided for the creation of a brightness distribution on said object (6).
- 4. (Currently Amended) A scanning system as defined in Claim 3, characterized in that wherein by means of said aperture array (3) a plurality of object points (6') can be detected, there being provided at least as many groups of sensor elements (13, 14) as there are object points (6') to be detected.
- 5. (Currently Amended) A scanning system as defined in any one of Claims 1 to 4, characterized in that claim 4, wherein means for deflecting (8) said observed beam path (7) are disposed in said observed beam path (7) between said object (6) and said sensors (10).

66489-111-7

6. (Currently Amended) A scanning system as defined in Claim 5, characterized in that wherein said deflecting means (8) is a beam splitter.

- 7. (Currently Amended) A scanning system as defined in Claim 5 or Claim 6, characterized in that , wherein said deflecting means (8) is disposed between said imaging optics (4) and said light source (1).
- 8. (Currently Amended) A scanning system as defined in Claim 3 or Claim 4 in conjunction with Claim 5 or 6, characterized in that , wherein said deflecting means (8) is disposed between said aperture array (3) and said light source (1).
- 9. (Currently Amended) A scanning system as defined in Claim 3, characterized in that wherein a moveable aperture (12) is provided which at least partially shades said sensor elements (13, 14) depending on the amount of movement of said aperture.
- 10. (Currently Amended) A scanning system as defined in Claim 9, characterized in that wherein said aperture (12) is designed such that movement of said aperture (12) causes a reduction of the shading of the at least one sensor element (13) and an increase in the shading of said at least one other sensor element (14).
- 11. (Currently Amended) A scanning system as defined in Claim 9 or Claim 10, characterized in that, wherein said aperture (12) shades, in an initial position, a part of said sensor elements (13) completely and, in an

66489-111-7

end position, another part of said sensor elements (14)-completely and, in an intermediate position, shades both a part of certain sensor elements (13)-and a part of the other certain sensor elements (14).

- 12. (Currently Amended) A scanning system as defined in any one of Claims 2 and from 9 to 11, characterized in that claim 11, wherein the degree of shading of said part of said sensor element (13) is complementary to the degree of non-shading of the other part of said sensor element (14).
- 13. (Currently Amended) A scanning system as defined in any one of Claims 2 to 8, characterized in that claim 2, wherein said means consists of an electronically controlled optical element (25) of variable translucence, in particular an LCD element.
- 14. (Currently Amended) A scanning system as defined in any one of Claims 3 to 13, characterized in that claim 13, wherein said aperture array (3) is designed for two-dimensional scanning of said object (6).
- 15. (Currently Amended) A scanning system as defined in Claim 14, characterized in that wherein regulating means are provided for adjusting the position of said aperture array (3) such that regions not imaged in a first scan due to the pulse duty ratio of said aperture array (3) are imaged in a second scan.

Preliminary Amendment dated September 19, 2006 Serial No.: PCT/EP2005/051276 66489-111-7

16. (Currently Amended) A scanning system as defined in any one of Claims 1 to 14, characterized in that claim 1, wherein said image detector (10) is a line sensor (10.2).

- 17. (Currently Amended) A scanning system as defined in any one of Claims 1 to 14, characterized in that claim 1, wherein said image detector (10) a flat panel sensor (10.3).
- 18. (Currently Amended) A scanning system as defined in any one of Claims 1 to 17, characterized in that claim 1, wherein said image detector (10) is in the form of a CCD sensor.
- 19. (Currently Amended) A scanning system as defined in any one of Claims 1 to 17, characterized in that claim 1, wherein said image detector (10) is in the form of a CMOS sensor.
- 20. (Currently Amended) A scanning system as defined in any one of Claims 1 to 11, characterized in that claim 1, wherein said sensor elements (13, 14) are disposed on separated image detectors (10, 10') and a beam splitter (24) is provided in the observed beam path which transfers the same image to said second image detector (10'), crossfading between the two image detectors (10, 10') being effected by means of electronic and/or optical auxiliaries during the scanning period (T).

- 21. (Currently Amended) A scanning configuration as defined in any one of Claims 1 to 12, characterized in that claim 1, wherein at least two sensor elements (13, 14) are used and the sensitivity of one part of said sensor elements (13) increases while that of the other part of said sensor elements (14) decreases with increased adjustment.
- 22. (Currently Amended) A scanning configuration as defined in any one of Claims 1 to 20, characterized in that claim 1 wherein the average scanning distance of said aperture array (3) is in accord with the desired measuring accuracy.
- 23. (Currently Amended) A scanning method based on the principle of confocal microscopy, in which light (5)-is emitted from a light source (1) onto an object (6)-to be scanned, which the light (5)-is focused by imaging optics (4), and also in which the light (7)-of an object point (6') backscattered from the object-(6) and passed back through the same imaging optics (4) is received by an image detector-(10) with has at least two radiation-sensitive sensor elements (13.14), characterized in thatwherein

at least two sensor elements (13, 14) are assigned to an object point illuminated via the imaging optics (4, 9),

the optical distance (d) of the image plane is varied during the exposure period (T) in a specific manner via means (11)-disposed in the optical path between the aperture array (3)- and the object (6), and

66489-111-7

the relationship between the accumulation of charges (Q13, Q14) produced in the at least two sensor elements (13, 14) and representing the intensity of the light in the observed beam path (7) can be modified such that a correlation between said accumulation and the optical distance (d) of the image plane from the imaging optics (4) is produced such that an altitude coordinate (zs) of the object (6) can be reconstructed from the distribution of the levels of intensity acquired by the at least two sensor elements (13, 14) during an exposure period (T).